

**Search Notes**

Application/Control No.

10/635,067

Examiner

Khai M. Nguyen

Applicant(s)/Patent under  
Reexamination

LIANG ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	41.2 41.1 63.1 63.3 67.13 114.2	1/3/2007	KN
370	338 341	1/3/2007	KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached)	1/3/2007	KN